

Substitute for Form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(use as many sheets as necessary)</i>				Complete if Known	
Application Number		10 617 940			
Filing Date		Filed Herewith			
First Named Inventor		Joseph P. Downes, et al.			
Group Art Unit					
Examiner Name					
Sheet	1	of	3	Attorney Docket Number	GSIL 0117 PUSA 1

U.S. PATENT DOCUMENTS						
Examiner Initials ¹	Cite No. ¹	U.S. PATENT DOCUMENT		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number	Kind Code ² (if known)			
SMH		4,156,124		Macken, et al.	05/22/1979	
		4,220,842		Sturmer, et al.	09/02/1980	
		4,323,755		Nierenberg	04/06/1982	
		4,522,656		Kuhn-Kuhnenfeld	06/11/1985	
		4,586,053		Hughes	04/29/1986	
		4,734,558		Nakano, et al.	03/29/1988	
		4,758,848		Nakano	07/19/1988	
		4,922,077		Gordon	05/01/1990	
		4,945,204		Nakamura, et al.	07/31/1990	
		4,985,780		Garnier, et al.	01/15/1991	
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		5,357,077		Tsuruta	10/18/1994	
		5,521,628		Montgomery	05/28/1996	
		5,600,478		Stevens	02/04/1997	
		5,635,976		Thuren, et al.	06/03/1997	
		5,690,846		Okada, et al.	11/25/1997	
		5,719,372		Togari, et al.	02/17/1998	
		5,847,960		Cutler, et al.1	12/08/1998	
		5,932,119		Kaplan, et al.	08/03/1999	
		5,942,137		Kamir, et al.	08/24/1999	
SMH		5,965,042		Saitoh	10/12/1999	

FOREIGN PATENT DOCUMENTS								
Examiner Initials ¹	Cite No. ¹	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ³
		Office ³	Number ⁴	Kind Code ⁵ (if known)				
SMH		WO	96/16767		Komatsu Ltd.	06/06/1996		
SMH		WO	98/53949		SDL, Inc.	03/12/1998		

Examiner Signature	S. Heinrich	Date Considered	11-01-2004
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¹EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

² Unique citation designation number. ³ See attached Kinds of U.S. Patent Documents. ⁴ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁵ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

⁶ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁷ Applicant is to place a check mark here if English language Translation is attached.

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

Examiner Signature	S. Heinrich
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				Examiner Name	
Sheet	3	of	3	Attorney Docket Number	GSIL 0117 PUSA 1
OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS					
Examiner Initials *	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
SMH		MONTAGU, Galvanometric and Resonant Low Inertia Scanners, Laser Beam Scanning, Marcel-Dekker, 1985, pgs. 214-216			
SMH		HAYES, ORLAN, Marking Applications Now Encompass Many Materials, Laser Focus World, February 1997, pgs. 153-160			
SMH		ROSSI, BRIAN, Commercial Fiber Lasers Take On Industrial Markets, Laser Focus World, May 1997, pgs. 143-150			
SMH		Invention Disclosure entitled "Calibration System For Fine Die Alignment", shipping date 9/98 to Hewlett Packard			

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